Application/Control No. Applicant(s)/Patent Under Reexamination 10/600,377 HOU ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 1765 Duy-Vu N. Deo **U.S. PATENT DOCUMENTS Document Number** Date Classification Name Country Code-Number-Kind Code MM-YYYY US-5,395,804 03-1995 Ueda, Tohru 438/166 Α US-6,540,509 04-2003 Asano et al. 432/205 В С US-4,613,400 09-1986 Tam et al. 216/46 US-4,735,824 04-1988 Yamabe et al. 427/79 D US-Ε US-F ÙS-G US-Н US-US-J US-K US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U V W

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